

# PRELIMINARY DATA SHEET

# 128M bits SDRAM

# WTR (Wide Temperature Range) EDS12322GBH-TT (4M words × 32 bits)

# **Specifications**

• Density: 128M bits

Organization

— 1M words  $\times$  32 bits  $\times$  4 banks

• Package: 90-ball FBGA

Lead-free (RoHS compliant) and Halogen-free

• Power supply: VDD, VDDQ =  $1.8V \pm 0.1V$ 

• Clock frequency: 166MHz/133MHz (max.)

• 1KB page size

Row address: A0 to A11Column address: A0 to A7

· Four internal banks for concurrent operation

• Interface: LVCMOS

• Burst lengths (BL): 1, 2, 4, 8, full page

• Burst type (BT):

Sequential (1, 2, 4, 8, full page)

— Interleave (1, 2, 4, 8)

• /CAS Latency (CL): 3

• Precharge: auto precharge option for each burst

access

Driver strength: half, quarterRefresh: auto-refresh, self-refresh

• Refresh cycles: 4096 refresh cycles/64ms

· Operating ambient temperature range

— TA =  $-20^{\circ}$ C to  $+85^{\circ}$ C

#### **Features**

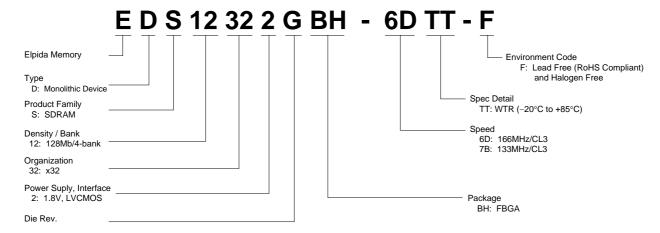
- ×32 organization
- Single pulsed /RAS
- Burst read/write operation and burst read/single write operation capability
- Byte control by DQM
- Wide temperature range
- TA =  $-20^{\circ}$ C to  $+85^{\circ}$ C

#### **Ordering Information**

Part number	Organization (words × bits)	Internal Banks	Clock frequency MHz (max.)	/CAS latency	Package
EDS12322GBH-6DTT-F	$4\text{M}\times32$	4	166	3	90-ball FBGA
EDS12322GBH-7BTT-F			133		

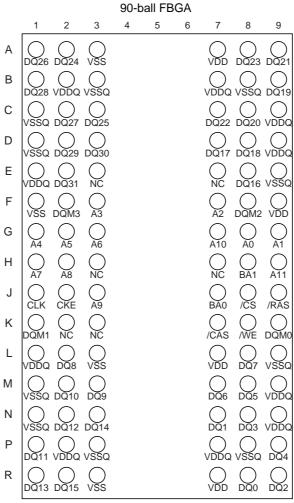
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#### **Part Number**



# **Pin Configurations**

/xxx indicates active low signal.



(Top view)

Pin name	Function	Pin name	Function
A0 to A11	Address inputs	CLK	Clock input
BA0, BA1	Bank select address	CKE	Clock enable
DQ0 to DQ31	Data-input/output	VDD	Power for internal circuit
/CS	Chip select	VSS	Ground for internal circuit
/RAS	Row address strobe	VDDQ	Power for DQ circuit
/CAS	Column address strobe	VSSQ	Ground for DQ circuit
/WE	Write enable	NC	No connection
DQM0 to DQM3	DQ mask enable		

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#### **Electrical Specifications**

- All voltages are referenced to VSS (GND).
- After power up, execute power up sequence and initialization sequence before proper device operation is achieved (refer to the Power up sequence).

#### **Absolute Maximum Ratings**

Parameter	Symbol	Rating	Unit	Note
Voltage on any pin relative to VSS	VT	-0.5 to VDD +0.3 (≤ 2.4 max.)	V	
Supply voltage relative to VSS	VDD	-0.5 to +2.4	V	_
Short circuit output current	IOS	50	mA	_
Power dissipation	PD	1.0	W	
Operating ambient temperature	TA	-20 to +85	°C	_
Storage temperature	Tstg	-55 to +125	°C	

#### Caution

Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

#### Recommended DC Operating Conditions (TA = $-20^{\circ}$ C to $+85^{\circ}$ C)

Parameter	Symbol	min.	max.	Unit	Notes
Supply voltage	VDD, VDDQ	1.7	1.9	V	1
<u></u>	VSS, VSSQ	0	0	V	2
Input high voltage	VIH	$0.8 \times VDD$	VDD + 0.3	V	3
Input low voltage	VIL	-0.3	0.3	V	4

Notes: 1. The supply voltage with all VDD and VDDQ pins must be on the same level.

- 2. The supply voltage with all VSS and VSSQ pins must be on the same level.
- 3. The peak of VIH = VDD + 0.5V (pulse width at VIH (max.)  $\leq$  3ns).
- 4. The bottom of VIL = VSS 1.0V (pulse width at VIL (min.)  $\leq 3ns$ ).

# DC Characteristics 1 (TA = -20°C to +85°C, VDD, VDDQ = 1.7V to 1.9V, VSS, VSSQ = 0V)

# Parameter

/CAS latency	Symbol	Grade	max.	Unit	Test condition	Notes
Operating current	IDD1	-6D -7B	55 50	mA	Burst length = 1, tRC = tRC (min.)	1, 2, 3
Standby current in power down	IDD2P		0.8	mA	CKE ≤ VIL (max.), tCK = tCK (min.)	6
Standby current in power down (input signal stable)	IDD2PS		0.6	mA	CKE ≤ VIL (max.), tCK = ∞	7
Standby current in non power down	IDD2N	-6D -7B	5.0 4.0	mA	CKE, /CS ≥ VIH (min.), tCK = tCK (min.)	4
Standby current in non power down (input signal stable)	IDD2NS		2.0	mA	CKE ≥ VIH (min.), tCK = ∞	8
Active standby current in power down	IDD3P		3.0	mA	CKE ≤ VIL (max.), tCK = tCK (min.)	1, 2, 6
Active standby current in power down (input signal stable)	IDD3PS		2.0	mA	CKE ≤ VIL (max.), tCK = ∞	2, 7
Active standby current in non power down	IDD3N		10	mA	CKE, /CS ≥ VIH (min.), tCK = tCK (min.)	1, 2, 4
Active standby current in non power down (input signal stable)	IDD3NS		7.0	mA	CKE ≥ VIH (min.), tCK = ∞	2, 8
Burst operating current	IDD4	-6D -7B	100 85	mA	tCK = tCK (min.), BL = 4	1, 2, 5
Refresh current	IDD5		50	mA	tRFC = tRFC (min.)	3
Self-refresh current	IDD6		3.0	mA	CKE ≤ VIL (max.)	

Notes: 1. IDD depends on output load condition when the device is selected. IDD (max.) is specified at the output open condition.

- 2. One bank operation.
- 3. Input signals are changed once per one clock.
- 4. Input signals are changed once per two clocks.
- 5. Input signals are changed once per four clocks.
- 6. After power down mode, CLK operating current.
- 7. After power down mode, no CLK operating current.
- 8. Input signals are VIH or VIL fixed.

# DC Characteristics 2 (TA = -20°C to +85°C, VDD, VDDQ = 1.7V to 1.9V, VSS, VSSQ = 0V)

Parameter	Symbol	min.	max.	Unit	Test condition	Notes
Input leakage current	ILI	-2.0	2.0	μΑ	0 ≤ VIN ≤ VDD	
Output leakage current	ILO	-1.5	1.5	μΑ	0 ≤ VOUT ≤ VDD, DQ = disable	9
Output high voltage	VOH	VDD – 0.2	_	V	IOH = -0.1mA	_
Output low voltage	VOL	_	0.2	V	IOL = 0.1mA	

# Pin Capacitance (TA = 25°C, VDD, VDDQ = 1.7V to 1.9V)

Parameter	Symbol	Pins	min.	typ.	max.	Unit	Notes
Input capacitance	CI1	CLK	1.5	_	4.0	pF	1, 2, 4
	CI2	Address, CKE, /CS /RAS, /CAS, /WE, DQM	1.5	_	4.0	pF	1, 2, 4
Data input/output capacitance	CI/O	DQ	2.0	_	5.0	pF	1, 2, 3, 4

Notes: 1. Capacitance measured with Boonton Meter or effective capacitance measuring method.

- 2. Measurement condition: f = 1MHz,  $0.5 \times VDDQ$ , 200mV swing.
- 3. DQM = VIH to disable DOUT.
- 4. This parameter is sampled and not 100% tested.

#### AC Characteristics (TA = -20°C to +85°C, VDD, VDDQ = 1.7V to 1.9V, VSS, VSSQ = 0V)

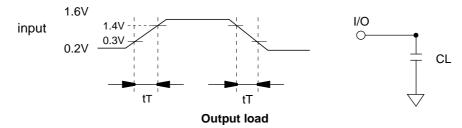
		-6D		-7B			
Parameter	Symbol	min.	max.	min.	max.	Unit	Notes
System clock cycle time	tCK	6	_	7.5	_	ns	1
CLK high pulse width	tCH	2.5	_	2.5	_	ns	1, 5
CLK low pulse width	tCL	2.5	_	2.5	_	ns	1, 5
Access time from CLK	tAC	_	5.4	_	6.0	ns	1, 2, 5
Data-out hold time	tOH	2.5	_	2.5	_	ns	1, 2, 5
CLK to Data-out low impedance	tLZ	0	_	0	_	ns	1, 2, 3, 5
CLK to Data-out high impedance	tHZ	_	5.4	_	6.0	ns	1, 4
Input setup time	tSI	1.5	_	1.5	_	ns	1, 5
Input hold time	tHI	0.8	_	0.8	_	ns	1, 5
Active to Ref/Active command period	tRC	67.5	_	67.5	_	ns	1
Refresh to Ref/Active command period	tRFC	80	_	80	_	ns	1
Self-refresh exit to Ref/Active command period	tSREX	120	_	120	_	ns	1
Active to Precharge command period	tRAS	45	120000	45	120000	ns	1
Active command to column command (same bank)	tRCD	18	_	22.5	_	ns	1
Precharge to active command period	tRP	18	_	22.5	_	ns	1
Write recovery or data-in to precharge lead time	tDPL	15	_	15	_	ns	1
Last data into active latency	tDAL	2CLK + tRP	_	2CLK + tRP	_		
Active (a) to Active (b) command period	tRRD	15	_	15	_	ns	1
Mode register set to active command period	tMRD	2	_	2	_	tCK	
Transition time (rise and fall)	tT	0.5	1.0	0.5	1.0	ns	
Refresh period (4096 refresh cycles)	tREF	_	64	_	64	ms	

Notes: 1. AC measurement assumes tT = 0.5ns. Reference level for timing of input signals is  $0.5 \times VDDQ$ .

- 2. Access time is measured at  $0.5 \times VDDQ$ . Load condition is CL = 30pF.
- 3. tLZ (min.) defines the time at which the outputs achieves the low impedance state.
- 4. tHZ (max.) defines the time at which the outputs achieves the high impedance state.
- If tT ≥ 1ns, each parameters is changed as follows;
   tAC, tOH, tLZ: should be added (tT (rise)/2 0.5)
   tCH, tCL, tSI, tHI: should be added {(tT (rise) + tT (fall))/2 1}

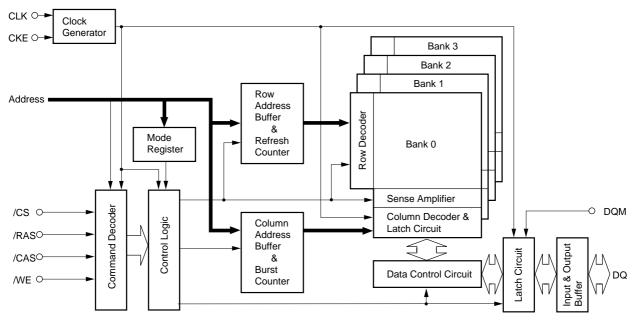
#### **Test Conditions**

- $\bullet$  Input and output timing reference levels: VDDQ  $\times\,0.5$
- Input waveform and output load: See following figures





# **Block Diagram**



#### Pin Function

#### **CLK** (input pin)

CLK is the master clock input. Other inputs signals are referenced to the CLK rising edge.

#### **CKE** (input pins)

CKE determine validity of the next CLK (clock). If CKE is high, the next CLK rising edge is valid; otherwise it is invalid. If the CLK rising edge is invalid, the internal clock is not issued and the Synchronous DRAM suspends operation.

When the Synchronous DRAM is not in burst mode and CKE is negated, the device enters power down mode. During power down mode, CKE must remain low.

#### /CS (input pins)

/CS low starts the command input cycle. When /CS is high, commands are ignored but operations continue.

## /RAS, /CAS, and /WE (input pins)

/RAS, /CAS and /WE have the same symbols on conventional DRAM but different functions. For details, refer to the command table.

#### A0 to A11 (input pins)

Row Address is determined by A0 to A11 at the CLK (clock) rising edge in the active command cycle.

Column Address is determined at the CLK rising edge in the read or write command cycle (See Address Pins table).

#### [Address Pins Table]

#### Address (A0 to A11)

Part number	Row address	Column address
EDS12322GBH	AX0 to AX11	AY0 to AY7

A10 defines the precharge mode. When A10 is high in the precharge command cycle, all banks are precharged; when A10 is low, only the bank selected by BA0 and BA1 is precharged.

When A10 is high in read or write command cycle, the precharge starts automatically after the burst access.

#### BA0 and BA1 (input pin)

BA0 and BA1 are bank select signal (BS). (See Bank Select Signal Table)

#### [Bank Select Signal Table]

	BA0	BA1
Bank 0	L	L
Bank 1	Н	L
Bank 2	L	Н
Bank 3	Н	Н

Remark: H: VIH. L: VIL.

#### DQM0 to DQM3 (input pins)

DQM controls I/O buffers. In read mode, DQM controls the output buffers like a conventional /OE pin. DQM high and DQM low turn the output buffers off and on, respectively. The DQM latency for the read is two clocks. In write mode, DQM controls the word mask. Input data is written to the memory cell if DQM is low but not if DQM is high. The DQM latency for the write is zero.

Each DQM pin corresponds to eight DQ pins, respectively (See DQM Correspondence Table).



# DQ0 to DQ31 (input/output pins)

DQ pins have the same function as I/O pins on a conventional DRAM.

# [DQM Correspondence Table]

Organization	Data mask	DQs	
× 32 bits	DQM0	DQ0 to DQ7	
	DQM1	DQ8 to DQ15	
	DQM2	DQ16 to DQ23	
	DQM3	DQ24 to DQ31	

# VDD, VSS, VDDQ, VSSQ (Power supply)

VDD and VSS are power supply pins for internal circuits. VDDQ and VSSQ are power supply pins for the output buffers.



#### **Command Operation**

#### **Command Truth Table**

The SDRAM recognizes the following commands specified by the /CS, /RAS, /CAS, /WE and address pins.

CKE

		CKE									
Function	Symbol	n – 1	n	/CS	/RAS	/CAS	/WE	BA1	BA0	A10	Address
Device deselect	DESL	Н	×	Н	×	×	×	×	×	×	×
No operation	NOP	Н	×	L	Н	Н	Н	×	×	×	×
Burst stop	BST	Н	×	L	Н	Н	L	×	×	×	×
Read	READ	Н	×	L	Н	L	Н	V	V	L	V
Read with auto precharge	READA	Н	×	L	Н	L	Н	V	V	Н	V
Write	WRIT	Н	×	L	Н	L	L	V	V	L	V
Write with auto precharge	WRITA	Н	×	L	Н	L	L	V	V	Н	V
Bank activate	ACT	Н	×	L	L	Н	Н	V	V	V	V
Precharge select bank	PRE	Н	×	L	L	Н	L	V	V	L	×
Precharge all banks	PALL	Н	×	L	L	Н	L	×	×	Н	×
Mode register set	MRS	Н	×	L	L	L	L	L	L	L	V
Extended mode register set	EMRS	Н	×	L	L	L	L	Н	L	L	V

Remark: H: VIH. L: VIL. x: VIH or VIL. V: Valid address input.

#### Device deselect command [DESL]

When this command is set (/CS is high), the SDRAM ignore command input at the clock. However, the internal status is held.

#### No operation [NOP]

This command is not an execution command. However, the internal operations continue.

## **Burst stop command [BST]**

This command can stop the current burst operation.

#### Column address strobe and read command [READ]

This command starts a read operation. In addition, the start address of burst read is determined by the column address (see Address Pins Table in Pin Function) and the bank select address (BA0, BA1). After the read operation, the output buffer becomes high-Z.

#### Read with auto precharge [READA]

This command automatically performs a precharge operation after a burst read with a burst length of 1, 2, 4 or 8.

#### Column address strobe and write command [WRIT]

This command starts a write operation. When the burst write mode is selected, the column address (see Address Pins Table in Pin Function) and the bank select address (BA0, BA1) become the burst write start address. When the single write mode is selected, data is only written to the location specified by the column address (see Address Pins Table in Pin Function) and the bank select address (BA0, BA1).

#### Write with auto precharge [WRITA]

This command automatically performs a precharge operation after a burst write with a length of 1, 2, 4 or 8, or after a single write operation.



#### Row address strobe and bank activate [ACT]

This command activates the bank that is selected by BA0, BA1 and determines the row address (A0 to A11). (See Bank Select Signal Table)

#### Precharge selected bank [PRE]

This command starts precharge operation for the bank selected by BA0, BA1. (See Bank Select Signal Table)

# [Bank Select Signal Table]

	BA0	BA1
Bank 0	L	L
Bank 1	Н	L
Bank 2	L	Н
Bank 3	Н	Н

Remark: H: VIH. L: VIL.

#### Precharge all banks [PALL]

This command starts a precharge operation for all banks.

#### Refresh [REF/SELF]

This command starts the refresh operation. There are two types of refresh operation, the one is auto-refresh, and the other is self-refresh. For details, refer to the CKE truth table section.

#### Mode register set [MRS]

The SDRAM has a mode register that defines how it operates. The mode register is specified by the address pins (A0 to A11, BA0 and BA1) at the mode register set cycle. For details, refer to the mode register configuration. After power on, the contents of the mode register are undefined, execute the mode register set command to set up the mode register.

#### Extended mode register set [EMRS]

The SDRAM has an extended mode register that defines the driver strength (DS).



# **DQM Truth Table**

		CKE		DQM			
Function	Symbol	n – 1	n	0	1	2	3
Data write / output enable	ENB	Н	×	L	L	L	L
Data mask / output disable	MASK	Н	×	Н	Н	Н	Н
DQ0 to DQ7 write enable/output enable	ENB0	Н	×	L	×	×	×
DQ8 to DQ15 write enable/output enable	ENB1	Н	×	×	L	×	×
DQ16 to DQ23 write enable/output enable	ENB2	Н	×	×	×	L	×
DQ24 to DQ31 write enable/output enable	ENB3	Н	×	×	×	×	L
DQ0 to DQ7 write inhibit/output disable	MASK0	Н	×	Н	×	×	×
DQ8 to DQ15 write inhibit/output disable	MASK 1	Н	×	×	Н	×	×
DQ16 to DQ23 write inhibit/output disable	MASK 2	Н	×	×	×	Н	×
DQ24 to DQ31 write inhibit/output disable	MASK 3	Н	×	×	×	×	Н

Remark: H: VIH. L: VIL. x: VIH or VIL

# **CKE Truth Table**

			CKE						
Current state	Function	Symbol	n – 1	n	/CS	/RAS	/CAS	/WE	Address
Activating	Clock suspend mode entry		Н	L	×	×	×	×	×
Any	Clock suspend mode		L	L	×	×	×	×	×
Clock suspend	Clock suspend mode exit		L	Н	×	×	×	×	×
Idle	CBR (auto) refresh command	REF	Н	Н	L	L	L	Н	×
Idle	Self-refresh entry	SELF	Н	L	L	L	L	Н	×
Self-refresh	Self-refresh exit		L	Н	L	Н	Н	Н	×
			L	Н	Н	×	×	×	×
Idle	Power down entry		Н	L	L	Н	Н	Н	×
			Н	L	Н	×	×	×	×
Power down	Power down exit		L	Н	Н	×	×	×	×
			L	Н	L	Н	Н	Н	×

Remark: H: VIH. L: VIL. x: VIH or VIL



#### **Function Truth Table**

The following table shows the operations that are performed when each command is issued in each mode of the SDRAM.

The following table assumes that CKE is high.

Prechange         H         x         x         x         x         x         DESL         Enter IDLE after IRP           L         H         H         H         X         NOP         Enter IDLE after IRP           L         H         H         L         X         BST         ILLEGAL           L         H         L         H         BA, CA, A10         READ/READA         ILLEGAL*3           L         L         H         L         BA, CA, A10         WRIT/WRITA         ILLEGAL*3           L         L         H         H         BA, CA, A10         WRIT/WRITA         ILLEGAL*3           L         L         L         H         X         REF, SELF         ILLEGAL           L         L         L         L         MODE         MRS         ILLEGAL           L         L         L         L         MODE         MRS         ILLEGAL           Idle         H         H         X         X         DESL         NOP           Idle         H         H         H         X         NOP         NOP           Idle         H         H         H         X         NOP         NO	Current state	/CS	/RAS	/CAS	/WE	Address	Command	Operation
L H H L L X BST   ILLEGAL     L H L H BA, CA, A10 READ/READA   ILLEGAL*3     L H L H BA, CA, A10 WRITWRITA   ILLEGAL*3     L L H L BA, RA ACT   ILLEGAL*3     L L H L BA, A10 PRE, PALL NOP*5     L L L H X REF, SELF   ILLEGAL     L L L L MODE MRS ILLEGAL     L L L M MODE EMRS ILLEGAL     L H H X NOP NOP NOP     L H H H X NOP NOP NOP     L H H L X BST ILLEGAL     L H H L X BST ILLEGAL     L H H H X NOP NOP NOP     L H H H L X BST ILLEGAL     L H L H BA, CA, A10 WRITWRITA   ILLEGAL*4     L H L H BA, CA, A10 WRITWRITA   ILLEGAL*6     L H L H BA, RA ACT BARK and row active     L L H L BA, A10 PRE, PALL NOP     L L H K X REF, SELF Refresh     L L H H X REF, SELF REFRESH     L L H H X REF, SELF REFRESH     L H H H X REF, SELF REFRESH     L H H H X REF, SELF REFRESH     L H H H X REP, SELF REPRESH     L H H H X REP, SELF REPRESH     L H H H X REP, SELF REPRESH     L H H H R X REP, SELF REPRESH     L H H H R REPRESH REPRESH     L H H H R REPRESH REPR	Precharge	Н	×	×	×	×	DESL	Enter IDLE after tRP
L H L H BA, CA, A10 READ/READA   ILLEGAL*3		L	Н	Н	Н	×	NOP	Enter IDLE after tRP
L H L L BA, CA, A10 WRIT/WRITA   ILLEGAL*3		L	Н	Н	L	×	BST	ILLEGAL
		L	Н	L	Н	BA, CA, A10	READ/READA	ILLEGAL*3
L		L	Н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL*3
L		L	L	Н	Н	BA, RA	ACT	ILLEGAL*3
L		L	L	Н	L	BA, A10	PRE, PALL	NOP*5
L		L	L	L	Н	×	REF, SELF	ILLEGAL
H		L	L	L	L	MODE	MRS	ILLEGAL
L		L	L	L	L	MODE	EMRS	ILLEGAL
L	Idle	Н	×	×	×	×	DESL	NOP
L		L	Н	Н	Н	×	NOP	NOP
L H L L BA, CA, A10 WRIT/WRITA ILLEGAL*4  L L H H BA, RA ACT Bank and row active  L L H L BA, A10 PRE, PALL NOP  L L L H X REF, SELF Refresh  L L L L MODE MRS Mode register set*8  L L L L MODE EMRS Extended mode register set*8  Row active  H X X X X X DESL NOP  L H H H X X NOP NOP  L H H H X X BST ILLEGAL  L H BA, CA, A10 READ/READA Begin read*6  L H L BA, CA, A10 WRIT/WRITA Begin write*6  L H BA, RA ACT Other bank active ILLEGAL on same bank*2  L L H K BA, A10 PRE, PALL Precharge*7  L L H X REF, SELF ILLEGAL  L H X REF, SELF ILLEGAL  L H X REF, SELF ILLEGAL		L	Н	Н	L	×	BST	ILLEGAL
L         L         H         H         BA, RA         ACT         Bank and row active           L         L         H         L         BA, A10         PRE, PALL         NOP           L         L         L         H         X         REF, SELF         Refresh           L         L         L         L         MODE         MRS         Mode register set*8           L         L         L         L         MODE         EMRS         Extended mode register set*8           Row active         H         X         X         X         X         DESL         NOP           L         H         H         X         X         X         DESL         NOP           L         H         H         H         X         NOP         NOP         NOP           L         H         H         L         X         BST         ILLEGAL           L         H         L         L         BA, CA, A10         WRIT/WRITA         Begin write*6           L         L         H         H         BA, RA         ACT         Other bank active ILLEGAL on same bank*2           L         L         L         H         <		L	Н	L	Н	BA, CA, A10	READ/READA	ILLEGAL*4
L		L	Н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL*4
L         L         L         H         ×         REF, SELF         Refresh           L         L         L         L         MODE         MRS         Mode register set*8           L         L         L         L         MODE         EMRS         Extended mode register set*8           Row active         H         X         X         X         X         DESL         NOP           L         H         H         H         X         NOP         NOP           L         H         H         L         X         BST         ILLEGAL           L         H         L         H         BA, CA, A10         READ/READA         Begin read*6           L         H         L         L         BA, CA, A10         WRIT/WRITA         Begin write*6           L         L         H         H         BA, RA         ACT         Other bank active ILLEGAL on same bank*2           L         L         L         H         X         REF, SELF         ILLEGAL           L         L         L         H         X         REF, SELF         ILLEGAL		L	L	Н	Н	BA, RA	ACT	Bank and row active
L L L MODE MRS Mode register set*8  L L L MODE EMRS Extended mode register set*8  Row active  H X X X X X DESL NOP  L H H H X NOP NOP  L H H L X BST ILLEGAL  L H L H BA, CA, A10 READ/READA Begin read*6  L H L BA, CA, A10 WRIT/WRITA Begin write*6  L L H H BA, RA ACT Other bank active ILLEGAL on same bank*2  L L H L BA, A10 PRE, PALL Precharge*7  L L L H X REF, SELF ILLEGAL  L L L MODE MRS ILLEGAL		L	L	Н	L	BA, A10	PRE, PALL	NOP
Row active   H		L	L	L	Н	×	REF, SELF	Refresh
H		L	L	L	L	MODE	MRS	Mode register set*8
L H H L X BST ILLEGAL  L H L H BA, CA, A10 READ/READA Begin read*6  L H L L BA, CA, A10 WRIT/WRITA Begin write*6  L L H H BA, RA ACT Other bank active ILLEGAL on same bank*2  L L H L BA, A10 PRE, PALL Precharge*7  L L L H X REF, SELF ILLEGAL  L L L MODE MRS ILLEGAL		L	L	L	L	MODE	EMRS	Extended mode register set*8
L H H L × BST ILLEGAL  L H L H BA, CA, A10 READ/READA Begin read*6  L H L L BA, CA, A10 WRIT/WRITA Begin write*6  L L H H BA, RA ACT Other bank active ILLEGAL on same bank*2  L L H L BA, A10 PRE, PALL Precharge*7  L L L H × REF, SELF ILLEGAL  L L L MODE MRS ILLEGAL	Row active	Н	×	×	×	×	DESL	NOP
L H L H BA, CA, A10 READ/READA Begin read*6  L H L L BA, CA, A10 WRIT/WRITA Begin write*6  L L H H BA, RA ACT Other bank active ILLEGAL on same bank*2  L L H L BA, A10 PRE, PALL Precharge*7  L L L H X REF, SELF ILLEGAL  L L L MODE MRS ILLEGAL		L	Н	Н	Н	×	NOP	NOP
L H L L BA, CA, A10 WRIT/WRITA Begin write* <sup>6</sup> L L H H BA, RA ACT Other bank active ILLEGAL on same bank* <sup>2</sup> L L H L BA, A10 PRE, PALL Precharge* <sup>7</sup> L L L H × REF, SELF ILLEGAL  L L MODE MRS ILLEGAL		L	Н	Н	L	×	BST	ILLEGAL
L L H H BA, RA ACT Other bank active ILLEGAL on same bank*2  L L H L BA, A10 PRE, PALL Precharge*7  L L L H × REF, SELF ILLEGAL  L L L MODE MRS ILLEGAL		L	Н	L	Н	BA, CA, A10	READ/READA	Begin read*6
L L H H BA, RA ACT ILLEGAL on same bank*2  L L H L BA, A10 PRE, PALL Precharge*7  L L L H × REF, SELF ILLEGAL  L L L MODE MRS ILLEGAL		L	Н	L	L	BA, CA, A10	WRIT/WRITA	Begin write*6
L L L MODE MRS ILLEGAL		L	L	Н	Н	BA, RA	ACT	
L L L MODE MRS ILLEGAL		L	L	Н	L	BA, A10	PRE, PALL	Precharge*7
		L	L	L	Н	×	REF, SELF	ILLEGAL
L L L MODE EMRS ILLEGAL		L	L	L	L	MODE	MRS	ILLEGAL
		L	L	L	L	MODE	EMRS	ILLEGAL



Current state	/CS	/RAS	/CAS	/WE	Address	Command	Operation
Read	Н	×	×	×	×	DESL	Continue burst to end
	L	Н	Н	Н	×	NOP	Continue burst to end
	L	Н	Н	L	×	BST	Burst stop
	L	Н	L	Н	BA, CA, A10	READ/READA	Continue burst read to /CAS latency and New read
	L	Н	L	L	BA, CA, A10	WRIT/WRITA	Term burst read/start write
	L	L	Н	Н	BA, RA	ACT	Other bank active ILLEGAL on same bank*2
	L	L	Н	L	BA, A10	PRE, PALL	Term burst read and Precharge
	L	L	L	Н	×	REF, SELF	ILLEGAL
	L	L	L	L	MODE	MRS	ILLEGAL
	L	L	L	L	MODE	EMRS	ILLEGAL
Read with auto precharge	Н	×	×	×	×	DESL	Continue burst to end and precharge
	L	Н	Н	Н	×	NOP	Continue burst to end and precharge
	L	Н	Н	L	×	BST	ILLEGAL
	L	Н	L	Н	BA, CA, A10	READ/READA	ILLEGAL*3
	L	Н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL*3
	L	L	Н	Н	BA, RA	ACT	Other bank active ILLEGAL on same bank*2
	L	L	Н	L	BA, A10	PRE, PALL	ILLEGAL*3
	L	L	L	Н	×	REF, SELF	ILLEGAL
	L	L	L	L	MODE	MRS	ILLEGAL
	L	L	L	L	MODE	EMRS	ILLEGAL
Write	Н	×	×	×	×	DESL	Continue burst to end
	L	Н	Н	Н	×	NOP	Continue burst to end
	L	Н	Н	L	×	BST	Burst stop
	L	Н	L	Н	BA, CA, A10	READ/READA	Term burst and New read
	L	Н	L	L	BA, CA, A10	WRIT/WRITA	Term burst and New write
	L	L	Н	Н	BA, RA	ACT	Other bank active ILLEGAL on same bank*3
	L	L	Н	L	BA, A10	PRE, PALL	Term burst write and Precharge*1
	L	L	L	Н	×	REF, SELF	ILLEGAL
	L	L	L	L	MODE	MRS	ILLEGAL
	L	L	L	L	MODE	EMRS	ILLEGAL



Current state	/CS	/RAS	/CAS	/WE	Address	Command	Operation
Write with auto precharge	Н	×	×	×	×	DESL	Continue burst to end and precharge
	L	Н	Н	Н	×	NOP	Continue burst to end and precharge
	L	Н	Н	L	×	BST	ILLEGAL
	L	Н	L	Н	BA, CA, A10	READ/READA	ILLEGAL*3
	L	Н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL*3
	L	L	Н	Н	BA, RA	ACT	Other bank active ILLEGAL on same bank*3
	L	L	Н	L	BA, A10	PRE, PALL	ILLEGAL*3
	L	L	L	Н	×	REF, SELF	ILLEGAL
	L	L	L	L	MODE	MRS	ILLEGAL
	L	L	L	L	MODE	EMRS	ILLEGAL
Refresh (auto-refresh)	Н	×	×	×	×	DESL	Enter IDLE after tRC
	L	Н	Н	Н	×	NOP	Enter IDLE after tRC
	L	Н	Н	L	×	BST	ILLEGAL
	L	Н	L	Н	BA, CA, A10	READ/READA	ILLEGAL*4
	L	Н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL*4
	L	L	Н	Н	BA, RA	ACT	ILLEGAL*4
	L	L	Н	L	BA, A10	PRE, PALL	ILLEGAL*4
	L	L	L	Н	×	REF, SELF	ILLEGAL
	L	L	L	L	MODE	MRS	ILLEGAL
	L	L	L	L	MODE	EMRS	ILLEGAL
Mode register set	Н	X	×	×	×	DESL	NOP
	L	Н	Н	Н	×	NOP	NOP
	L	Н	Н	L	×	BST	ILLEGAL
	L	Н	L	Н	BA, CA, A10	READ/READA	ILLEGAL*4
	L	Н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL*4
	L	L	Н	Н	BA, RA	ACT	Bank and row active*9
	L	L	Н	L	BA, A10	PRE, PALL	NOP
	L	L	L	Н	×	REF, SELF	Refresh*9
	L	L	L	L	MODE	MRS	Mode register set*8
	L	L	L	L	MODE	EMRS	Extended mode register set*8
Extended mode register set	Н	×	×	×	×	DESL	NOP
	L	Н	Н	Н	×	NOP	NOP
	L	Н	Н	L	×	BST	ILLEGAL
	L	Н	L	Н	BA, CA, A10	READ/READA	ILLEGAL*4
	L	Н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL*4
	L	L	Н	Н	BA, RA	ACT	Bank and row active*9
	L	L	Н	L	BA, A10	PRE, PALL	NOP
	L	L	L	Н	×	REF, SELF	Refresh*9
	L	L	L	L	MODE	MRS	Mode register set*8
		L	L	L	MODE	EMRS	Extended mode register set*8



Notes: 1. An interval of tDPL is required between the final valid data input and the precharge command.

- 2. If tRRD is not satisfied, this operation is illegal.
- 3. Illegal for same bank, except for another bank.
- 4. Illegal for all banks.
- 5. NOP for same bank, except for another bank.
- 6. Illegal if tRCD is not satisfied.
- 7. Illegal if tRAS is not satisfied.
- 8. MRS command must be issued after DOUT finished, in case of DOUT remaining.
- 9. Illegal if tMRD is not satisfied.



#### **Command Truth Table for CKE**

	CKE								
Current State	n – 1	n	/CS	/RAS	/CAS	/WE	Address	Operation	Notes
Self-refresh	Н	×	×	×	×	×	×	INVALID, CLK (n – 1) would exit self-refresh	
	L	Н	Н	×	×	×	×	Self-refresh recovery	
	L	Н	L	Н	Н	×	×	Self-refresh recovery	
	L	Н	L	Н	L	×	×	ILLEGAL	
	L	Н	L	L	×	×	×	ILLEGAL	
	L	L	×	×	×	×	×	Continue self-refresh	
Self-refresh recovery	Н	Н	Н	×	×	×	×	Idle after tRC	
	Н	Н	L	Н	Н	×	×	Idle after tRC	
	Н	Н	L	Н	L	×	×	ILLEGAL	
	Н	Н	L	L	×	×	×	ILLEGAL	
	Н	L	Н	×	×	×	×	ILLEGAL	
	Н	L	L	Н	Н	×	×	ILLEGAL	
	Н	L	L	Н	L	×	×	ILLEGAL	
	Н	L	L	L	×	×	×	ILLEGAL	
Power down	Н	×	×	×	×	×		INVALID, CLK (n – 1) would exit power down	
	L	Н	Н	×	×	×	×	EXIT power down	
	L	Н	L	Н	Н	Н	×	EXIT power down	
	L	L	×	×	×	×	×	Continue power down mode	
All banks idle	Н	Н	Н	×	×	×		Refer to operations in Function Truth Table	
	Н	Н	L	Н	×	×		Refer to operations in Function Truth Table	
	Н	Н	L	L	Н	×		Refer to operations in Function Truth Table	
	Н	Н	L	L	L	Н	×	Auto-refresh	
	Н	Н	L	L	L	L	OPCODE	Refer to operations in Function Truth Table	
	Н	L	Н	×	×	×		Begin power down next cycle	
	Н	L	L	Н	×	×		Refer to operations in Function Truth Table	
	Н	L	L	L	Н	×		Refer to operations in Function Truth Table	
	Н	L	L	L	L	Н	×	Self-refresh	1
	Н	L	L	L	L	L	OPCODE	Refer to operations in Function Truth Table	
	L	Н	×	×	×	×	×	Exit power down next cycle	
	L	L	×	×	×	×	×	Power down	1
Row active	Н	×	×	×	×	×	×	Refer to operations in Function Truth Table	
	L	×	×	×	×	×	×	Clock suspend	1
Any state other than	Н	Н	×	×	×	×		Refer to operations in Function Truth Table	
listed above	Н	L	×	×	×	×	×	Begin clock suspend next cycle	2
	L	Н	×	×	×	×	×	Exit clock suspend next cycle	
	L	L	×	×	×	×	×	Maintain clock suspend	

Remark: H: VIH. L: VIL. x: VIH or VIL

Notes: 1. Self-refresh can be entered only from the all banks idle state. Power down can be entered only from all banks idle. Clock suspend can be entered only from following states, row active, read, read with auto precharge, write and write with auto precharge.

2. Must be legal command as defined in Function Truth Table.



#### Clock suspend mode entry

The SDRAM enters clock suspend mode from active mode by setting CKE to low. If command is input in the clock suspend mode entry cycle, the command is valid. The clock suspend mode changes depending on the current status (1 clock before) as shown below.

#### **ACTIVE clock suspend**

This suspend mode ignores inputs after the next clock by internally maintaining the bank active status.

#### READ suspend and READ with Auto precharge suspend

The data being output is held (and continues to be output).

#### WRITE suspend and WRIT with Auto precharge suspend

In this mode, external signals are not accepted. However, the internal state is held.

#### Clock suspend

During clock suspend mode, keep the CKE to low.

#### Clock suspend mode exit

The SDRAM exits from clock suspend mode by setting CKE to high during the clock suspend state.

#### **IDLE**

In this state, all banks are not selected, and completed precharge operation.

#### Auto-refresh command [REF]

When this command is input from the IDLE state, the SDRAM starts auto-refresh operation. (The auto-refresh is the same as the CBR refresh of conventional DRAMs.) During the auto-refresh operation, refresh address and bank select address are generated inside the SDRAM. For every auto-refresh cycle, the internal address counter is updated. Accordingly, 4096 times are required to refresh the entire memory. Before executing the auto-refresh command, all the banks must be in the IDLE state. In addition, since the precharge for all banks is automatically performed after auto-refresh, no precharge command is required after auto-refresh.

#### Self-refresh entry [SELF]

When this command is input during the IDLE state, the SDRAM starts self-refresh operation. After the execution of this command, self-refresh continues while CKE is low. Since self-refresh is performed internally and automatically, external refresh operations are unnecessary.

#### Power down mode entry

When this command is executed during the IDLE state, the SDRAM enters power down mode. In power down mode, power consumption is suppressed by cutting off the initial input circuit.

#### Self-refresh exit

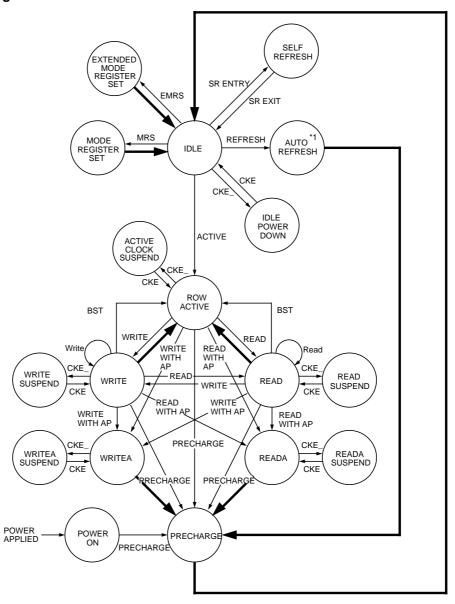
When this command is executed during self-refresh mode, the SDRAM can exit from self-refresh mode. After exiting from self-refresh mode, the SDRAM enters the IDLE state.

#### Power down exit

When this command is executed at the power down mode, the SDRAM can exit from power down mode. After exiting from power down mode, the SDRAM enters the IDLE state.



# **Simplified State Diagram**



- Automatic transition after completion of command.
- Transition resulting from command input.

Note: 1. After the auto-refresh operation, precharge operation is performed automatically and enter the IDLE state.

#### Mode Register and Extended Mode Register Configuration

#### **Mode Register Set**

The mode register is set by the input to the address pins (A0 to A11, BA0 and BA1) during mode register set cycles. The mode register consists of five sections, each of which is assigned to address pins.

BA1, BA0, A8, A9, A10, A11: (OPCODE): The SDRAM has two types of write modes. One is the burst write mode, and the other is the single write mode. These bits specify write mode.

Burst read and burst write: Burst write is performed for the specified burst length starting from the column address specified in the write cycle.

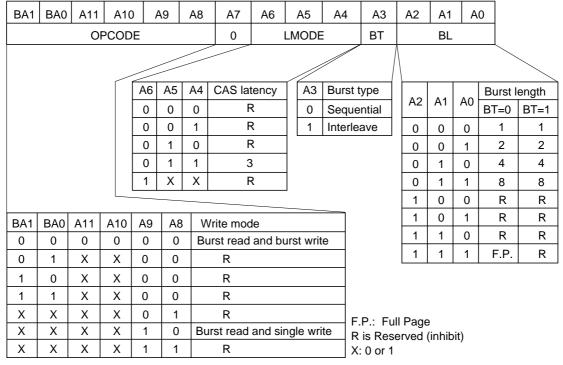
Burst read and single write: Data is only written to the column address specified during the write cycle, regardless of the burst length.

A7: Keep this bit low at the mode register set cycle. If this pin is high, the vender test mode is set.

A6, A5, A4: (LMODE): These pins specify the /CAS latency.

A3: (BT): A burst type is specified.

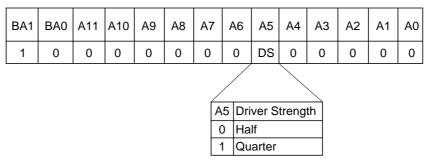
A2, A1, A0: (BL): These pins specify the burst length.



**Mode Register Set** 

#### **Extended Mode Register Set**

A5 and A6: These pins specify driver strength.



**Extended Mode Register Set** 

#### **Burst Sequence**

Burst length = 2

Starting Ad.	Addressing(decimal)					
A0	Sequential	Interleave				
0	0, 1,	0, 1,				
1	1, 0,	1, 0,				

Burst length = 4

Starti	ng Ad.	Addressing(decimal)							
A1	A0	Sequential Interleave							
0	0	0, 1, 2, 3, 0, 1, 2, 3,							
0	1	1, 2, 3, 0, 1, 0, 3, 2,							
1	0	2, 3, 0, 1, 2, 3, 0, 1,							
1	1	3, 0, 1, 2, 3, 2, 1, 0,							

#### Burst length = 8

Star	ting A	ing Ad. Addressing(decimal)					
A2	A1	A0	Sequential	Interleave			
0	0	0	0, 1, 2, 3, 4, 5, 6, 7,	0, 1, 2, 3, 4, 5, 6, 7,			
0	0	1	1, 2, 3, 4, 5, 6, 7, 0,	1, 0, 3, 2, 5, 4, 7, 6,			
0	1	0	2, 3, 4, 5, 6, 7, 0, 1,	2, 3, 0, 1, 6, 7, 4, 5,			
0	1	1	3, 4, 5, 6, 7, 0, 1, 2,	3, 2, 1, 0, 7, 6, 5, 4,			
1	0	0	4, 5, 6, 7, 0, 1, 2, 3,	4, 5, 6, 7, 0, 1, 2, 3,			
1	0	1	5, 6, 7, 0, 1, 2, 3, 4,	5, 4, 7, 6, 1, 0, 3, 2,			
1	1	0	6, 7, 0, 1, 2, 3, 4, 5,	6, 7, 4, 5, 2, 3, 0, 1,			
1	1	1	7, 0, 1, 2, 3, 4, 5, 6,	7, 6, 5, 4, 3, 2, 1, 0,			

# **Burst Sequence**

Full page burst is available only for sequential addressing. The addressing sequence is started from the column address that is asserted by read/write command. And the address is increased one by one.

It is back to the address 0 when the address reaches at the end of address 255. "Full page burst" stops the burst read/write with burst stop command.

#### **Power-up Sequence**

## **Power-up Sequence**

- 1. Apply VDD and VDDQ at the same time. Keep CKE low during power up.
- 2. Wait for stable power.
- 3. Start clock and drive CKE high.

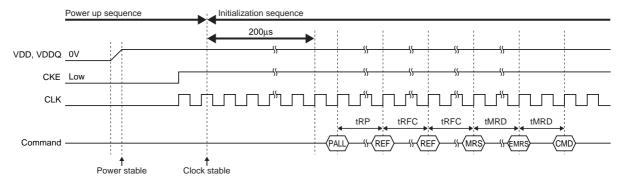
Note: Voltage on any input pin must not exceed VDD + 0.3V during power up.

#### **Initialization Sequence**

- 4. After stable power and stable clock, wait 200 µs.
- 5. Issue precharge all command (PALL).
- 6. After tRP delay, issue 8 or more auto-refresh commands (REF).
- 7. Issue the mode register set command (MRS) to program the mode register.

  After tMRD of the MRS command, issue the extended mode register set command (EMRS) to program the extended mode register.

Note: We recommend that you keep DQM and CKE high during initialization sequence to prevent data contention on the DQ bus.



**Power-up Sequence and Initialization Sequence** 

#### Operation of the SDRAM

#### **Read/Write Operations**

#### **Bank Active**

Before executing a read or write operation, the corresponding bank and the row address must be activated by the bank active (ACT) command. An interval of tRCD is required between the bank active command input and the following read/write command input.

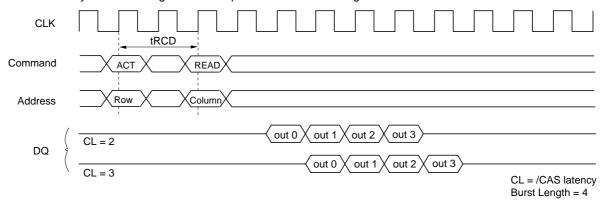
#### **Read Operation**

A read operation starts when a read command is input. Output buffer becomes low-Z in the (/CAS Latency - 1) cycle after read command set. The SDRAM can perform a burst read operation.

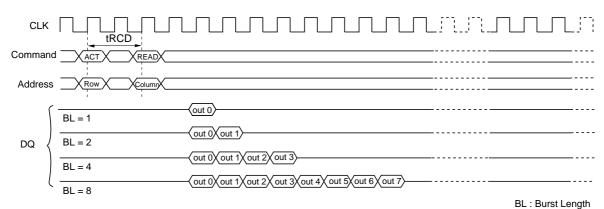
The burst length can be set to 1, 2, 4 and 8. The start address for a burst read is specified by the column address and the bank select address at the read command set cycle. In a read operation, data output starts after the number of clocks specified by the /CAS Latency. The /CAS Latency can be set to 2 or 3.

When the burst length is 1, 2, 4 and 8 the DOUT buffer automatically becomes high-Z at the next clock after the successive burst-length data has been output.

The /CAS latency and burst length must be specified at the mode register.



/CAS Latency



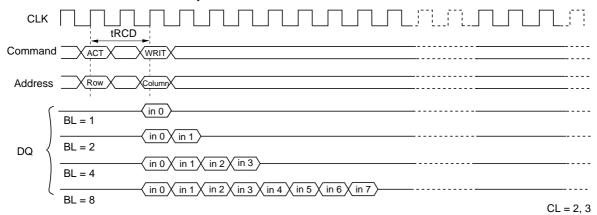
/CAS Latency = 2

**Burst Length** 

#### **Write Operation**

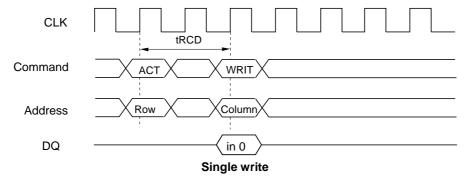
Burst write or single write mode is selected by the OPCODE of the mode register.

1. Burst write: A burst write operation is enabled by setting OPCODE (A9, A8) to (0, 0). A burst write starts in the same clock as a write command set. (The latency of data input is 0 clock.) The burst length can be set to 1, 2, 4 and 8, like burst read operations. The write start address is specified by the column address and the bank select address at the write command set cycle.



#### **Burst write**

2. Single write: A single write operation is enabled by setting OPCODE (A9, A8) to (1, 0). In a single write operation, data is only written to the column address and the bank select address specified by the write command set cycle without regard to the burst length setting. (The latency of data input is 0 clock).

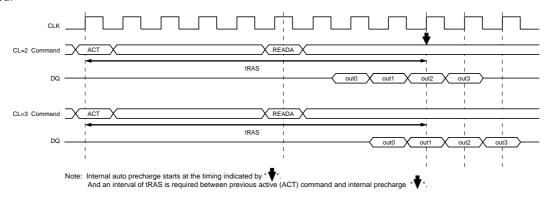


#### **Auto Precharge**

During a read or write command cycle, A10 controls whether auto precharge is selected. A10 high in the Read or Write command (Read with auto precharge command or Write with auto precharge command), auto precharge is selected and begins automatically. The tRAS must be satisfied with a read with auto precharge or a write with auto precharge operation. In addition, the next activate command to the bank being precharged cannot be executed until the precharge cycle ends.

# Read with Auto Precharge

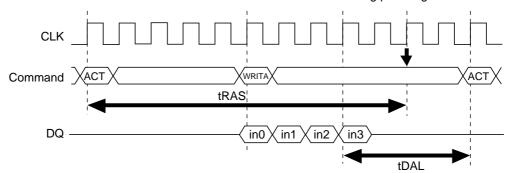
In read cycle, once auto precharge has started, an activate command to the bank can be issued after tRP has been satisfied.



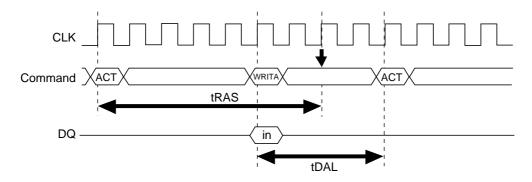
Burst Read (BL = 4)

#### Write with Auto Precharge

In write cycle, the auto precharge starts at the timing of two clocks after the last data word input to the device. The tDAL must be satisfied to issue the next activate command to the bank being precharged.



Burst Write (BL = 4)



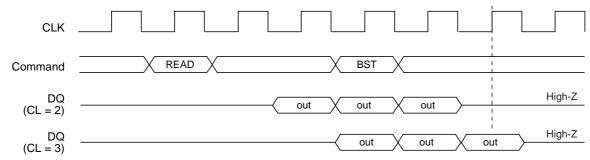
Note: Internal auto precharge starts at the timing indicated by " ♣ ".

and an interval of tRAS is required between previous active (ACT) command and internal precharge " ♣ ".

**Single Write** 

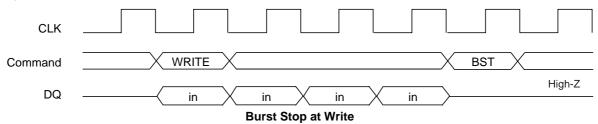
#### **Burst Stop Command**

During a read cycle, when the burst stop command is issued, the burst read data are terminated and the data bus goes to high-Z after the /CAS latency from the burst stop command.



**Burst Stop at Read** 

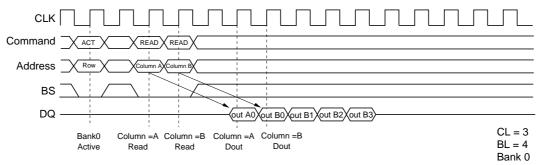
During a write cycle, when the burst stop command is issued, the burst write data are terminated and data bus goes to high-Z at the same clock with the burst stop command.



#### **Command Intervals**

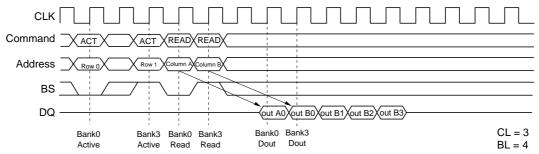
#### **Read Command to Read Command Interval**

 Same bank, same ROW address: When another read command is executed at the same ROW address of the same bank as the preceding read command execution, the second read can be performed after an interval of no less than 1 clock. Even when the first command is a burst read that is not yet finished, the data read by the second command will be valid.



READ to READ Command Interval (same ROW address in same bank)

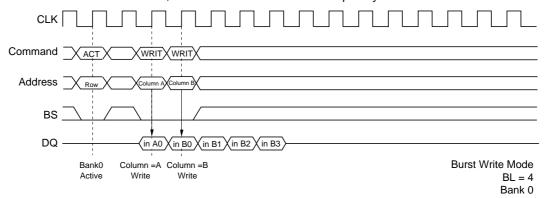
- 2. Same bank, different ROW address: When the ROW address changes on same bank, consecutive read commands cannot be executed; it is necessary to separate the two read commands with a precharge command and a bank active command.
- 3. Different bank: When the bank changes, the second read can be performed after an interval of no less than 1 clock, provided that the other bank is in the bank active state. Even when the first command is a burst read that is not yet finished, the data read by the second command will be valid.



**READ to READ Command Interval (different bank)** 

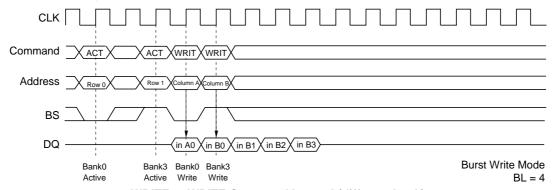
#### **Write Command to Write Command Interval**

1. Same bank, same ROW address: When another write command is executed at the same ROW address of the same bank as the preceding write command, the second write can be performed after an interval of no less than 1 clock. In the case of burst writes, the second write command has priority.



WRITE to WRITE Command Interval (same ROW address in same bank)

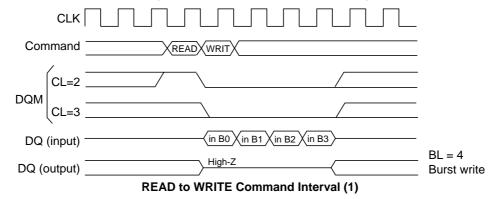
- Same bank, different ROW address: When the ROW address changes, consecutive write commands cannot be executed; it is necessary to separate the two write commands with a precharge command and a bank active command.
- 3. Different bank: When the bank changes, the second write can be performed after an interval of no less than 1 clock, provided that the other bank is in the bank active state. In the case of burst write, the second write command has priority.

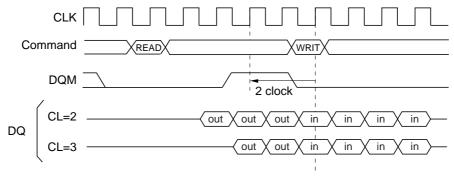


WRITE to WRITE Command Interval (different bank)

#### **Read Command to Write Command Interval**

1. Same bank, same ROW address: When the write command is executed at the same ROW address of the same bank as the preceding read command, the write command can be performed after an interval of no less than 1 clock. However, DQM must be set high so that the output buffer becomes high-Z before data input.



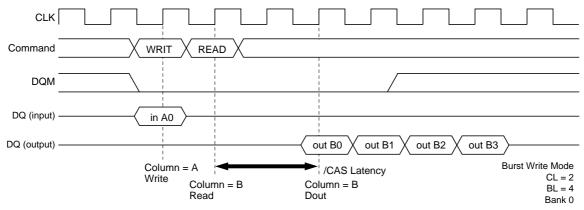


**READ to WRITE Command Interval (2)** 

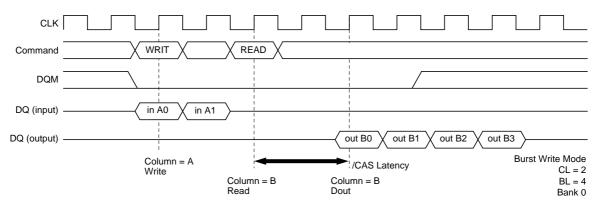
- 2. Same bank, different ROW address: When the ROW address changes, consecutive write commands cannot be executed; it is necessary to separate the two commands with a precharge command and a bank active command.
- 3. Different bank: When the bank changes, the write command can be performed after an interval of no less than 1 cycle, provided that the other bank is in the bank active state. However, DQM must be set high so that the output buffer becomes high-Z before data input.

#### Write Command to Read Command Interval:

 Same bank, same ROW address: When the read command is executed at the same ROW address of the same bank as the preceding write command, the read command can be performed after an interval of no less than 1 clock. However, in the case of a burst write, data will continue to be written until one clock before the read command is executed.



**WRITE to READ Command Interval (1)** 

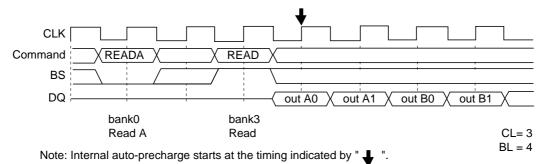


**WRITE to READ Command Interval (2)** 

- Same bank, different ROW address: When the ROW address changes, consecutive read commands cannot be executed; it is necessary to separate the two commands with a precharge command and a bank active command.
- 3. Different bank: When the bank changes, the read command can be performed after an interval of no less than 1 clock, provided that the other bank is in the bank active state. However, in the case of a burst write, data will continue to be written until one clock before the read command is executed (as in the case of the same bank and the same address).

#### Read with Auto Precharge to Read Command Interval

1. Different bank: When some banks are in the active state, the second read command (another bank) is executed. Even when the first read with auto precharge is a burst read that is not yet finished, the data read by the second command is valid. The internal auto precharge of one bank starts at the next clock of the second command.

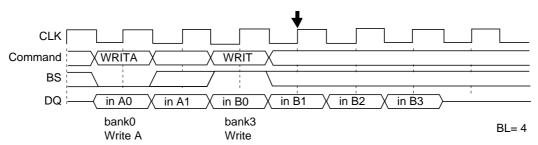


#### Read with Auto Precharge to Read Command Interval (Different bank)

2. Same bank: The consecutive read command (the same bank) is illegal.

#### Write with Auto Precharge to Write Command Interval

1. Different bank: When some banks are in the active state, the second write command (another bank) is executed. In the case of burst writes, the second write command has priority. The internal auto precharge of one bank starts two clocks later from the second command.



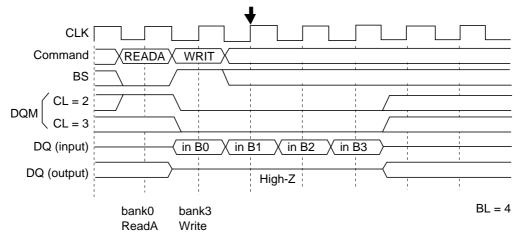
Note: Internal auto-precharge starts at the timing indicated by " ... ".

# Write with Auto Precharge to Write Command Interval (Different bank)

2. Same bank: The consecutive write command (the same bank) is illegal.

#### Read with Auto Precharge to Write Command Interval

1. Different bank: When some banks are in the active state, the second write command (another bank) is executed. However, DQM must be set high so that the output buffer becomes high-Z before data input. The internal auto precharge of one bank starts at the next clock of the second command.



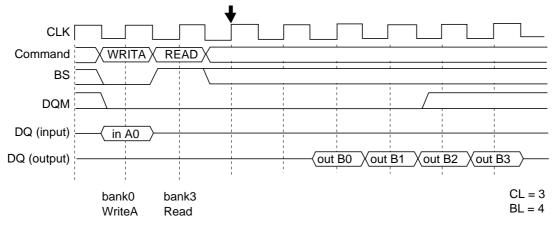
Note: Internal auto-precharge starts at the timing indicated by " lacksquare ".

#### Read with Auto Precharge to Write Command Interval (Different bank)

2. Same bank: The consecutive write command from read with auto precharge (the same bank) is illegal. It is necessary to separate the two commands with a bank active command.

#### Write with Auto Precharge to Read Command Interval

1. Different bank: When some banks are in the active state, the second read command (another bank) is executed. However, in case of a burst write, data will continue to be written until one clock before the read command is executed. The internal auto precharge of one bank starts at two clocks later from the second command.



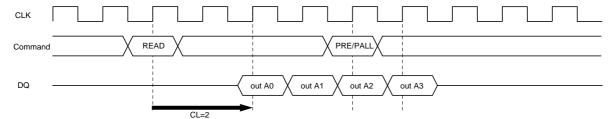
Note: Internal auto-precharge starts at the timing indicated by " ...

# Write with Auto Precharge to Read Command Interval (Different bank)

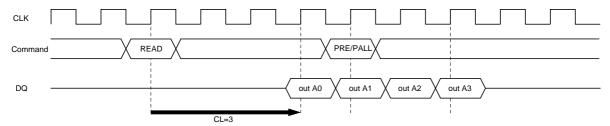
2. Same bank: The consecutive read command from write with auto precharge (the same bank) is illegal. It is necessary to separate the two commands with a bank active command.

#### Read Command to Precharge Command Interval (same bank)

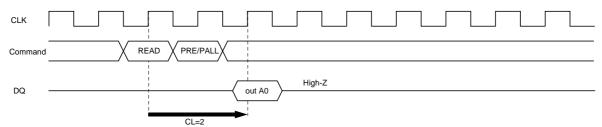
When the precharge command is executed for the same bank as the read command that preceded it, the minimum interval between the two commands is one clock.



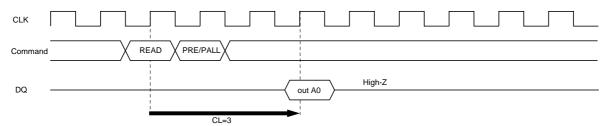
READ to PRECHARGE Command Interval (same bank): To output all data (CL = 2, BL = 4)



READ to PRECHARGE Command Interval (same bank): To output all data (CL = 3, BL = 4)



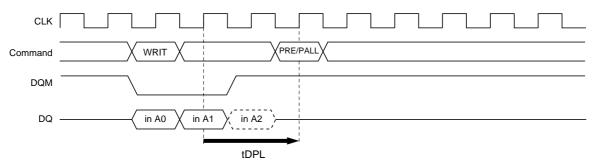
READ to PRECHARGE Command Interval (same bank): To stop output data (CL = 2, BL = 1, 2, 4, 8)



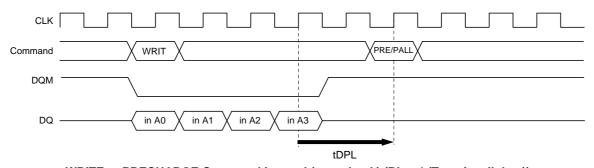
READ to PRECHARGE Command Interval (same bank): To stop output data (CL = 3, BL = 1, 2, 4, 8)

## Write Command to Precharge Command Interval (same bank)

When the precharge command is executed for the same bank as the write command that preceded it, the minimum interval between the two commands is 1 clock. However, if the burst write operation is unfinished, the input data must be masked by means of DQM for assurance of the clock defined by tDPL.



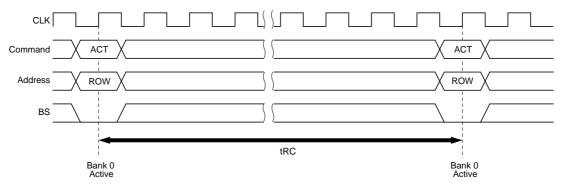
WRITE to PRECHARGE Command Interval (same bank) (BL = 4 (To stop write operation))



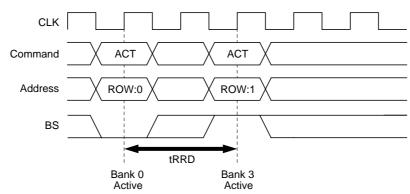
WRITE to PRECHARGE Command Interval (same bank) (BL = 4 (To write all data))

### **Bank Active Command Interval**

- 1. Same bank: The interval between the two bank active commands must be no less than tRC.
- 2. In the case of different bank active commands: The interval between the two bank active commands must be no less than tRRD.



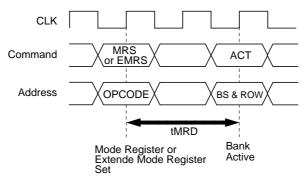
Bank Active to Bank Active for Same Bank



**Bank Active to Bank Active for Different Bank** 

# Mode Register or Extended Mode Register Set to Bank Active Command Interval

The interval between setting the mode register or extended mode register and executing a bank active command must be no less than tMRD.



Mode register set to Bank active command interval

### **DQM Control**

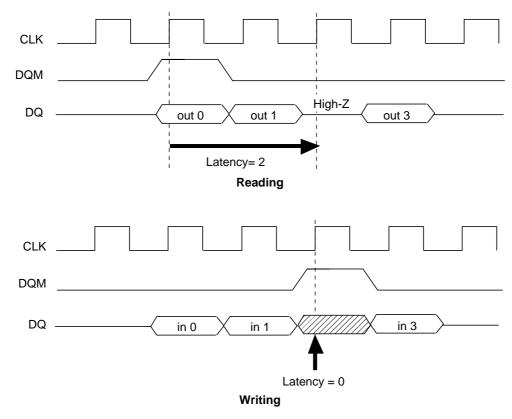
The DQM controls data mask function for read and write. Each DQM masks corresponding byte. DQM latency is different between reading and writing.

## Reading

When data is read, the output buffer can be controlled by DQM. By setting DQM to low, the output buffer becomes low-Z, enabling data output. By setting DQM to high, the output buffer becomes high-Z, and the corresponding data is not output. However, internal reading operations continue. The latency of DQM during reading is two clocks.

### Writing

Input data can be masked by DQM. By setting DQM to low, data can be written. In addition, when DQM is set to high, the corresponding data is not written, and the previous data is held. The latency of DQM during writing is 0 clock.



#### Refresh

#### **Auto-Refresh**

All the banks must be precharged before executing an auto-refresh command. Since the auto-refresh command updates the internal counter every time it is executed and determines the banks and the ROW addresses to be refreshed, external address specification is not required. The refresh cycles are required to refresh all the ROW addresses within tREF (max.). The output buffer becomes high-Z after auto-refresh start. In addition, since a precharge has been completed by an internal operation after the auto-refresh, an additional precharge operation by the precharge command is not required.

#### Self-Refresh

After executing a self-refresh command, the self-refresh operation continues while CKE is held low. During self-refresh operation, all ROW addresses are refreshed by the internal refresh timer. A self-refresh is terminated by a self-refresh exit command. Before and after self-refresh mode, execute auto-refresh to all refresh addresses in or within tREF (max.) period on the condition 1 and 2 below.

- 1. Enter self-refresh mode within time as below\* after either burst refresh or distributed refresh at equal interval to all refresh addresses are completed.
- 2. Start burst refresh or distributed refresh at equal interval to all refresh addresses within time as below\*after exiting from self-refresh mode.

Note: tREF (max.) / refresh cycles.

### **Others**

### **Power-Down Mode**

The SDRAM enters power-down mode when CKE goes low in the IDLE state. In power down mode, power consumption is suppressed by deactivating the input initial circuit. Power down mode continues while CKE is held low. In addition, by setting CKE to high, the SDRAM exits from the power down mode, and command input is enabled from the next clock. In this mode, internal refresh is not performed.

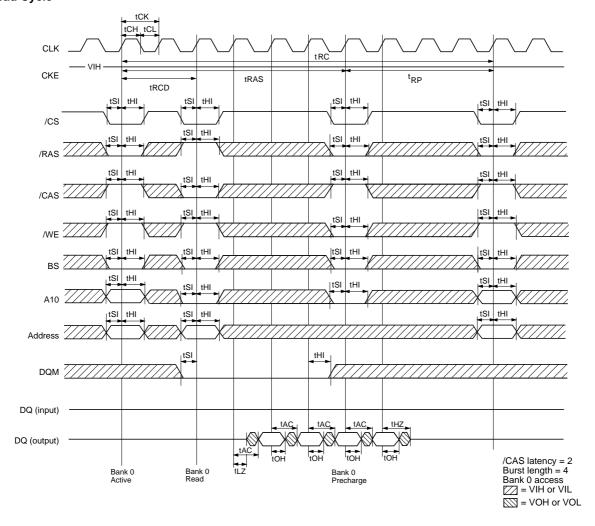
#### **Clock Suspend Mode**

By driving CKE to low during a bank active or read/write operation, the SDRAM enters clock suspend mode. During clock suspend mode, external input signals are ignored and the internal state is maintained. When CKE is driven high, the SDRAM terminates clock suspend mode, and command input is enabled from the next clock. For details, refer to the "CKE Truth Table".

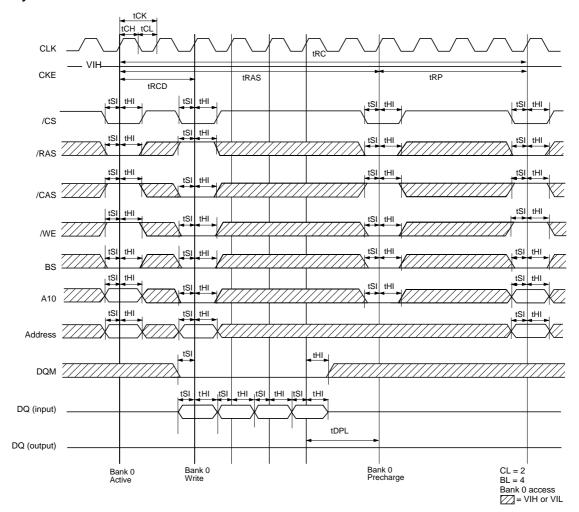


# **Timing Waveforms**

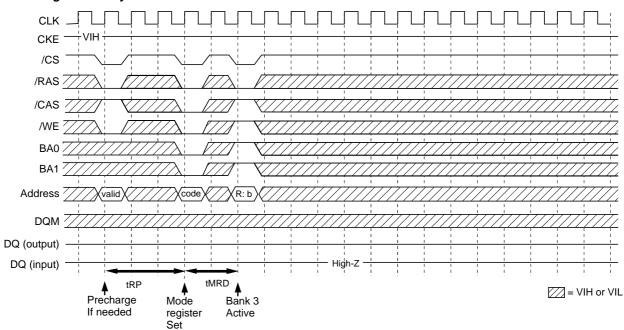
# **Read Cycle**



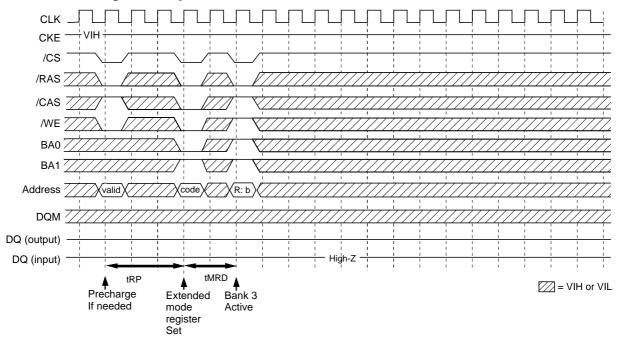
## **Write Cycle**



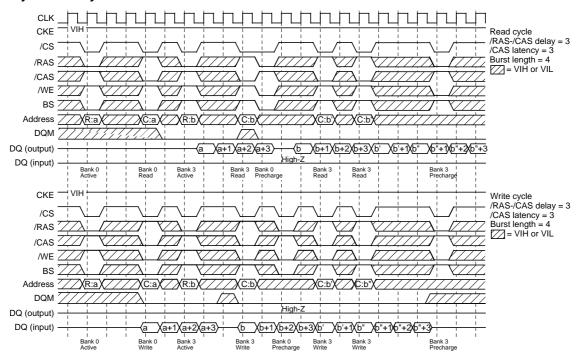
# **Mode Register Set Cycle**



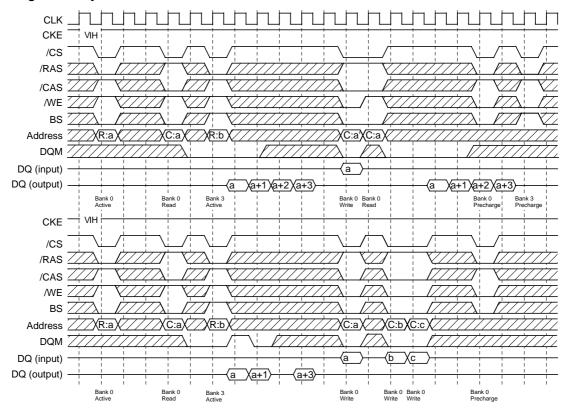
# **Extended Mode Register Set Cycle**



## Read Cycle/Write Cycle



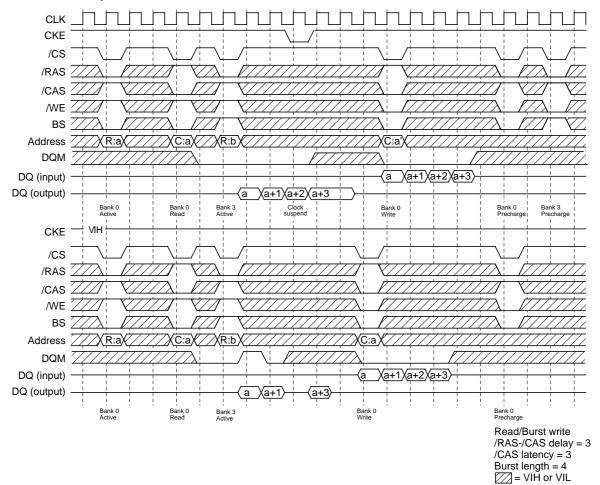
# **Read/Single Write Cycle**



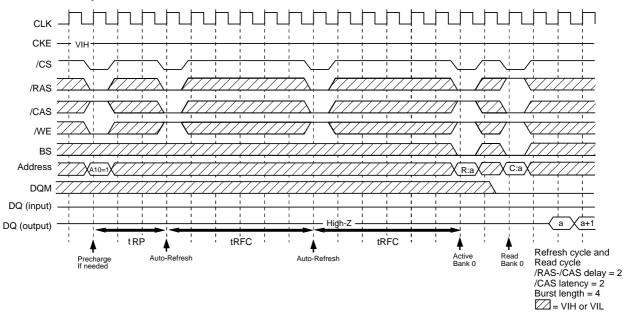
Read/Single write
/RAS-/CAS delay = 3
/CAS latency = 3
Burst length = 4
// = VIH or VIL



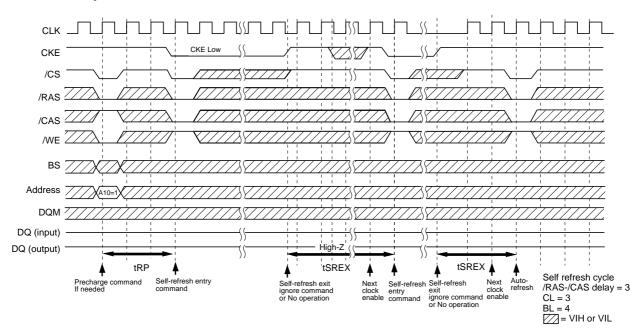
## **Read/Burst Write Cycle**



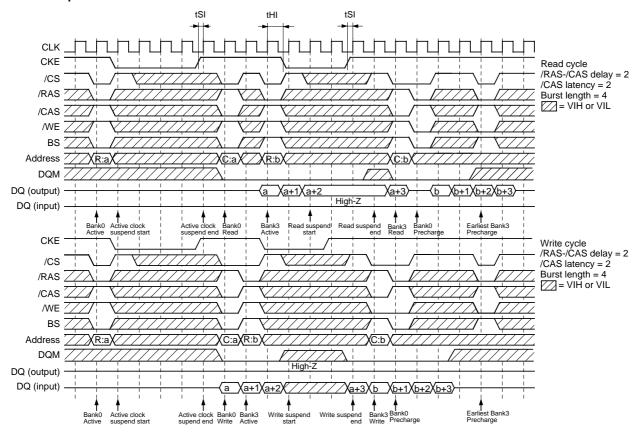
# **Auto-Refresh Cycle**



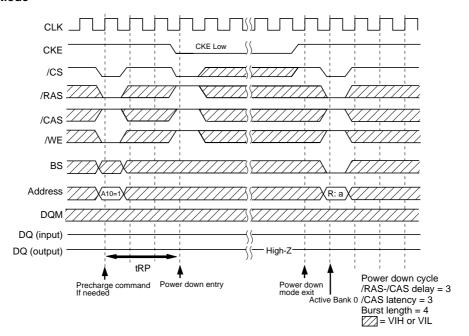
## Self-Refresh Cycle



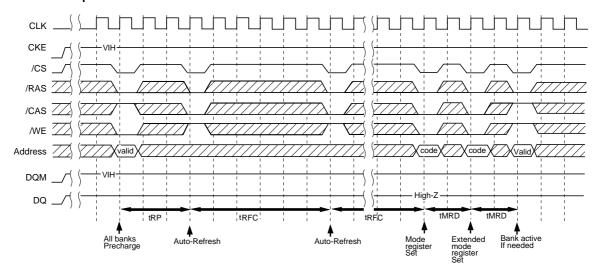
## **Clock Suspend Mode**



## **Power Down Mode**



# **Initialization Sequence**

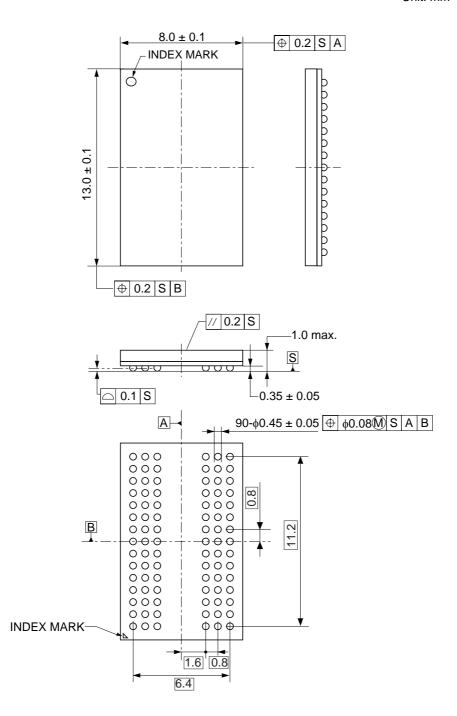


## **Package Drawing**

## 90-ball FBGA

Solder ball: Lead free (Sn-Ag-Cu)

Unit: mm



ECA-TS2-0238-01

# **Recommended Soldering Conditions**

Please consult with our sales offices for soldering conditions of the EDS12322GBH.

# **Type of Surface Mount Device**

EDS12322GBH: 90-ball FBGA < Lead free (Sn-Ag-Cu) >



### NOTES FOR CMOS DEVICES -

## (1) PRECAUTION AGAINST ESD FOR MOS DEVICES

Exposing the MOS devices to a strong electric field can cause destruction of the gate oxide and ultimately degrade the MOS devices operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it, when once it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. MOS devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. MOS devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor MOS devices on it.

# (2) HANDLING OF UNUSED INPUT PINS FOR CMOS DEVICES

No connection for CMOS devices input pins can be a cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. The unused pins must be handled in accordance with the related specifications.

## (3) STATUS BEFORE INITIALIZATION OF MOS DEVICES

Power-on does not necessarily define initial status of MOS devices. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the MOS devices with reset function have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. MOS devices are not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for MOS devices having reset function.

CME0107



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Usage in environments with special characteristics as listed below was not considered in the design. Accordingly, our company assumes no responsibility for loss of a customer or a third party when used in environments with the special characteristics listed below.

### Example:

- 1) Usage in liquids, including water, oils, chemicals and organic solvents.
- 2) Usage in exposure to direct sunlight or the outdoors, or in dusty places.
- 3) Usage involving exposure to significant amounts of corrosive gas, including sea air,  $CL_2$ ,  $H_2S$ ,  $NH_3$ ,  $SO_2$ , and  $NO_x$ .
- 4) Usage in environments with static electricity, or strong electromagnetic waves or radiation.
- 5) Usage in places where dew forms.
- 6) Usage in environments with mechanical vibration, impact, or stress.
- 7) Usage near heating elements, igniters, or flammable items.

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